

# Am25LS2518

Quad D Register with Standard and Three-State Outputs

## DISTINCTIVE CHARACTERISTICS

- Low-Power Schottky version of the popular Am2918 and Am25S18
- Four standard totem-pole outputs
- Four three-state outputs
- Four D-type flip-flops
- Second sourced by T. I. as the SN54/74LS388

## GENERAL DESCRIPTION

The Am25LS2518 consists of four D-type flip-flops with a buffered common clock. Information meeting the set-up and hold requirements on the D inputs is transferred to the Q outputs on the LOW-to-HIGH transition of the clock.

The same data as on the Q outputs is enabled at the three-state Y outputs when the "output control" ( $\overline{OE}$ ) input is LOW. When the  $\overline{OE}$  input is HIGH, the Y outputs are in the high-impedance state.

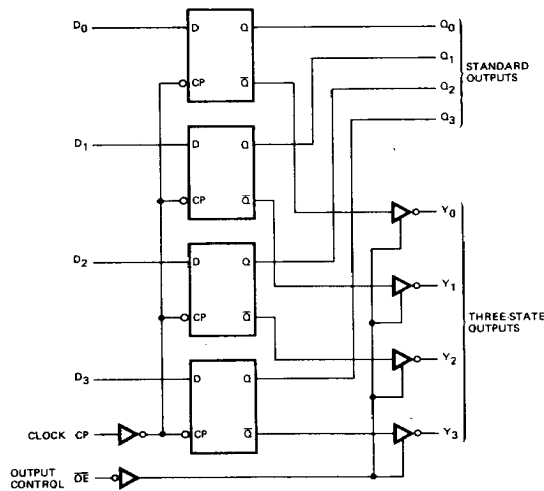
The Am25LS2518 is a 4-bit, high-speed register intended for use in real-time signal processing systems where the

standard outputs are used in a recursive algorithm and the three-state outputs provide access to a data bus to dump the results after a number of iterations.

The device can also be used as an address register or status register in computers or computer peripherals.

Likewise, the Am25LS2518 is also useful in certain display applications where the standard outputs can be decoded to drive LED's (or equivalent) and the three-state outputs are bus organized for occasional interrogation of the data as displayed.

## BLOCK DIAGRAM



## RELATED PRODUCTS

Part No.	Description
Am25S18	Quad D Register
Am2918	Quad D Register
Am29LS18	Quad D Low Power Register
Am29LS2519	Quad D Low Power Register

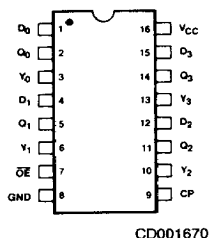
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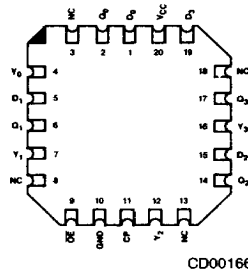
Refer to Page 13-1 for Essential Information on Military Devices

# CONNECTION DIAGRAM Top View

D-16, P-16

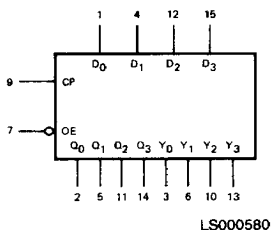


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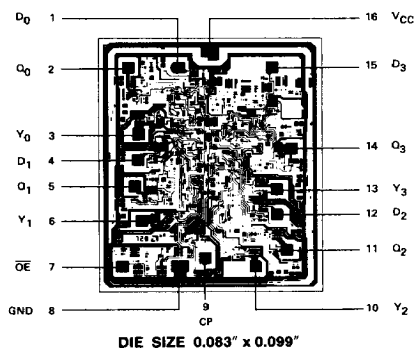


Note: Pin 1 is marked for orientation

## LOGIC SYMBOL



## METALLIZATION AND PAD LAYOUT



## ORDERING INFORMATION

AMD products are available in several packages and operating ranges. The order number is formed by a combination of the following: Device number, speed option (if applicable), package type, operating range and screening option (if desired).

Am25LS2518

D

C

B

Screening Option  
Blank - Standard processing  
B - Burn-in

Temperature (See Operating Range)  
C - Commercial (0°C to +70°C)  
M - Military (-55°C to +125°C)

Package

D - 16-pin Cerdip  
F - 16-pin flatpak  
L - 20-pin leadless chip carrier  
P - 16-pin plastic DIP  
X - Dice

Device type  
Quad D Register

### Valid Combinations

Am25LS2518	PC
	DC, DM
	FM
	LC, LM
	XC, XM

### Valid Combinations

Consult the AMD sales office in your area to determine if a device is currently available in the combination you wish.

## PIN DESCRIPTION

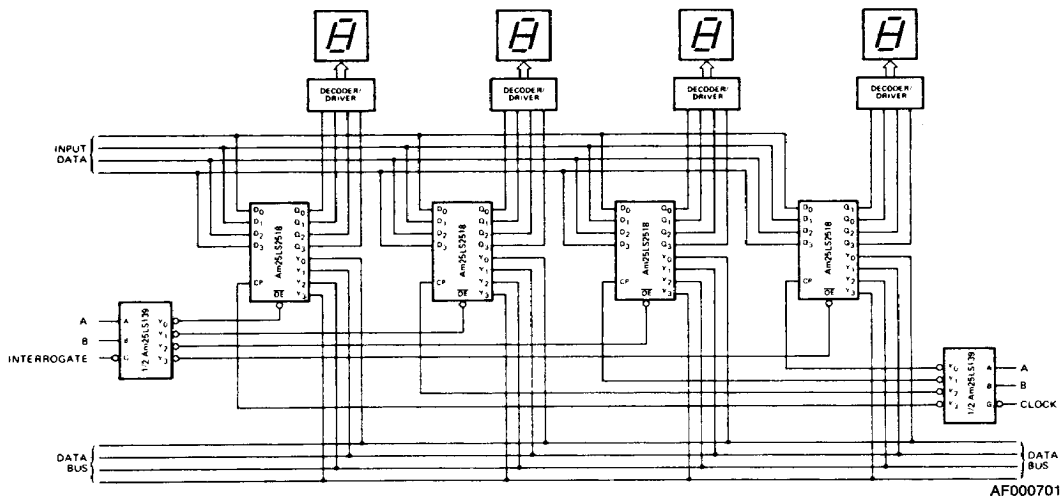
Pin No.	Name	I/O	Description
	$D_i$	I	The four data inputs to the register.
	$Q_i$	O	The four data outputs of the register with standard totem-pole active pull-up outputs. Data is passed non-inverted.
	$Y_i$	O	The four three-state data outputs of the register. When the three-state outputs are enabled, data is passed non-inverted. A HIGH on the "output control" input forces the $Y_i$ outputs to the high-impedance state.
9	CP	I	Clock. The buffered common clock for the register. Enters data on the LOW-to-HIGH transition.
7	$\overline{OE}$	I	Output Control. When the $\overline{OE}$ input is HIGH, the $Y_i$ outputs are in the high-impedance state. When the $\overline{OE}$ input is LOW, the TRUE register data is present at the $Y_i$ outputs.

## TRUTH TABLE

INPUTS			OUTPUTS		NOTES
$\overline{OE}$	CLOCK CP	D	Q	Y	
H	L	X	NC	Z	-
H	H	X	NC	Z	-
H	↑	L	L	Z	-
H	↑	H	H	Z	-
L	↑	L	L	L	-
L	↑	H	H	H	-
L	-	-	-	L	1
L	-	-	H	H	1

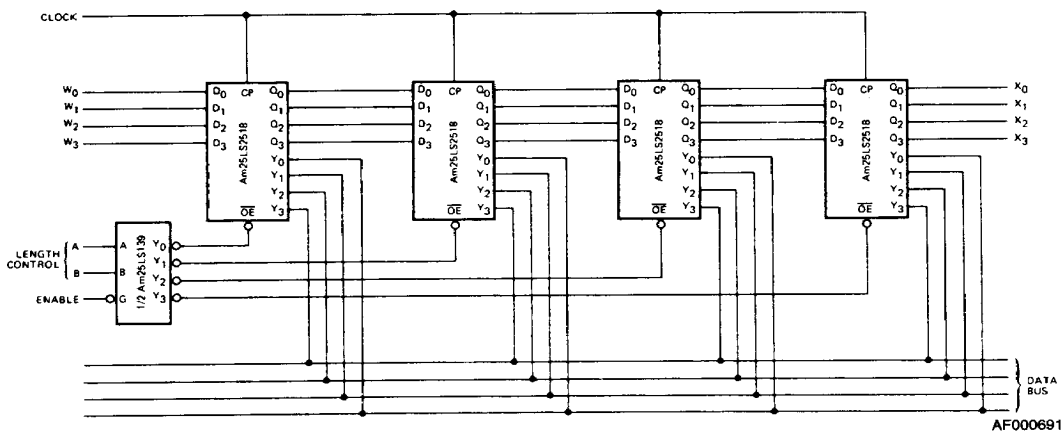
L = LOW                      NC = No change  
 H = HIGH                    ↑ = LOW-to-HIGH transition  
 X = Don't care              Z = High-Impedance  
 Note: 1. When  $\overline{OE}$  is LOW, the Y output will be in the same logic state as the Q output.

## APPLICATIONS



AF000701

The Am25LS2518 used as display register with bus interrogate capability.



AF000691

The Am25LS2518 as a variable length (1, 2, 3 or 4 word) shift register.

**ABSOLUTE MAXIMUM RATINGS**

Storage Temperature ..... -65°C to +150°C  
 (Ambient) Temperature Under Bias ..... -55°C to +125°C  
 Supply Voltage to Ground Potential  
   Continuous ..... -0.5V to +7.0V  
 DC Voltage Applied to Outputs For  
   High Output State ..... -0.5V to +V<sub>CC</sub> max  
 DC Input Voltage ..... -0.5V to +7.0V  
 DC Output Current, Into Outputs ..... 30mA  
 DC Input Current ..... -30mA to +5.0mA

Stresses above those listed under **ABSOLUTE MAXIMUM RATINGS** may cause permanent device failure. Functionality at or above these limits is not implied. Exposure to absolute maximum ratings for extended periods may affect device reliability.

**OPERATING RANGES**

Commercial (C) Devices

Temperature ..... 0°C to +70°C  
 Supply Voltage ..... +4.75V to +5.25V

Military (M) Devices

Temperature ..... -55°C to +125°C  
 Supply Voltage ..... +4.5V to +5.5V

Operating ranges define those limits over which the functionality of the device is guaranteed.

**DC CHARACTERISTICS** over operating range unless otherwise specified

Parameters	Description	Test Conditions (Note 2)		Min	Typ (Note 1)	Max	Units
V <sub>OH</sub>	Output HIGH Voltage	V <sub>CC</sub> = MIN V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	Q, I <sub>OH</sub> = -660μA	MIL	2.5	3.4	Volts
				COM'L	2.7	3.4	
			Y, I <sub>OH</sub> = -1.0mA	MIL	2.4	3.4	
				COM'L, I <sub>OH</sub> = -2.6mA	2.4	3.4	
V <sub>OL</sub>	Output LOW Voltage	V <sub>CC</sub> = MIN V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 4.0 mA			0.4	Volts
			I <sub>OL</sub> = 8.0mA			0.45	
			I <sub>OL</sub> = 12mA			0.5	
V <sub>IH</sub>	Input HIGH Level	Guaranteed input logical HIGH voltage for all inputs		2.0			Volts
V <sub>IL</sub>	Input LOW Level	Guaranteed input logical LOW voltage for all inputs.		MIL		0.7	Volts
				COM'L		0.8	
V <sub>I</sub>	Input Clamp Voltage	V <sub>CC</sub> = MIN, I <sub>IN</sub> = -18mA				-1.5	Volts
I <sub>IL</sub>	Input LOW Current	V <sub>CC</sub> = MAX, V <sub>IN</sub> = 0.4V				-0.36	mA
I <sub>IH</sub>	Input HIGH Current	V <sub>CC</sub> = MAX, V <sub>IN</sub> = 2.7V				20	μA
I <sub>I</sub>	Input HIGH Current	V <sub>CC</sub> = MAX, V <sub>IN</sub> = 7.0V				0.1	mA
I <sub>OZ</sub>	Off-State (High-Impedance) Output Current	V <sub>CC</sub> = MAX	V <sub>O</sub> = 0.4V			-20	μA
			V <sub>O</sub> = 2.4V			20	
I <sub>SC</sub>	Output Short Circuit Current (Note 3)	V <sub>CC</sub> = MAX		-15		-85	mA
I <sub>CC</sub>	Power Supply Current (Note 4)	V <sub>CC</sub> = MAX			17	28	mA

- Notes: 1. Typical limits are at V<sub>CC</sub> = 5.0V, 25°C ambient and maximum loading.  
 2. For conditions shown as MIN or MAX, use the appropriate value specified under Operating Ranges for the applicable device type.  
 3. Not more than one output should be shorted at a time. Duration of the short circuit test should not exceed one second.  
 4. I<sub>CC</sub> is measured with all inputs at 4.5V and all outputs open.

**SWITCHING CHARACTERISTICS** ( $T_A = +25^\circ\text{C}$ ,  $V_{CC} = 5.0\text{V}$ )

Parameters	Description		Test Conditions	Min	Typ	Max	Units	
tPLH	Clock to Qi		CL = 15pF RL = 2.0kΩ		18	27	ns	
tPHL					18	27		
tPLH	Clock to Yi (OE LOW)				18	27	ns	
tPHL					18	27		
tpw	Clock Pulse Width	LOW		18			ns	
		HIGH		15				
ts	Data			15			ns	
th	Data			5.0			ns	
tZH	OE to Yi			CL = 5.0pF RL = 2.0kΩ		7.0	11	ns
tZL						8	12	
tHZ	OE to Yi				14	21	ns	
tLZ					12	18		
fmax	Maximum Clock Frequency (Note 1)				35	50	MHz	

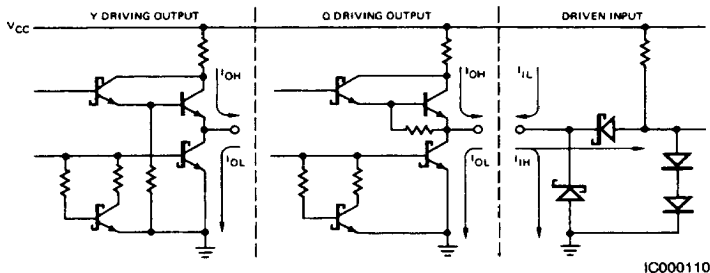
Note 1. Per industry convention,  $f_{max}$  is the worst case value of the maximum device operating frequency with no constraints on  $t_r$ ,  $t_f$ , pulse width or duty cycle.

**SWITCHING CHARACTERISTICS** over operating range unless otherwise specified\*

Parameters	Description	Test Conditions	COMMERCIAL		MILITARY		Units	
			Am25LS2518		Am25LS2518			
			Min	Max	Min	Max		
tPLH	Clock to Qi	CL = 50pF RL = 2.0kΩ		38		45	ns	
tPHL				38		45		
tPLH	Clock to Yi (OE LOW)			35		40	ns	
tPHL				35		40		
tpw	Clock Pulse Width		20		20		ns	
			20		20			
ts	Data		15		15		ns	
th	Data		5.0		5.0		ns	
tZH	OE to Yi			15		17	ns	
tZL				16		17		
tHZ	OE to Yi			27		30	ns	
tLZ				24		30		
fmax	Maximum Clock Frequency (Note 1)		30		25		MHz	

\*AC performance over the operating temperature range is guaranteed by testing defined in Group A, Subgroup 9.

### Am25LS2518 LOW-POWER SCHOTTKY INPUT/OUTPUT CURRENT INTERFACE CONDITIONS



IC000110

Note: Actual current flow direction shown.